On the Plasma Parameters in the High Power Impulse Magnetron Sputtering (HiPIMS) Discharge

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Introduction

- The demand for new materials and layer structures has lead to development of more advanced sputtering systems
- One such sputtering system is the
 - high power pulsed magnetron sputtering discharge (HPPMS)
 - high power impulse magnetron sputtering discharge (HiPIMS)
- It gives high electron density and highly ionized flux of the sputtered material
- The plasma parameters in the HiPIMS discharge will be reviewed

Introduction

- Magnetron Sputtering Discharge
- Ionized Physical Vapor Deposition (IPVD)
- High power impulse magnetron sputtering discharge (HiPIMS)
 - Power supply
 - Electron density
 - Plasma dynamics
 - Electron energy
 - Ionization fraction
 - Ion energy
 - Deposition rate
 - Applications
- Summary



Planar Magnetron Sputtering Discharge



- For a typical dc planar magnetron discharge
 - pressure of 1 10 mTorr
 - a magnetic field strength of 0.01 0.05 T
 - cathode potentials 300 700 V
 - electron density in the substrate vicinity is 10¹⁵ 10¹⁶ m⁻³
 - \blacksquare low fraction of the sputtered material is ionized \sim 1 %
 - the majority of ions are the ions of the inert gas
 - the sputtered vapor is mainly neutral

Planar Magnetron Sputtering Discharge



- In magnetron sputtering discharges increased ionized flux fraction is achieved by
 - a secondary discharge between the target and the substrate (rf coil or microwaves)
 - reshaping the geometry of the cathode to get more focused plasma (hollow cathode)
 - increasing the power to the cathode (high power pulse)
- Common to all highly ionized magnetron sputtering techniques is a very high density plasma

- When the flux of ions is higher than the flux of neutrals or Γ_i > Γ_m the process is referred to as ionized physical vapor deposition (IPVD)
- The metal ions can be accelerated to the substrate by means of a low voltage dc bias
 - The metal ions arrive at the substrate at normal incidence and at specific energy
 - The energy of the ions can be tailored to obtain impinging particles with energies comparable to typical surface and molecular binding energies
- Ionizing the sputtered vapor has several advantages:
 - improvement of the film quality
 - control of the reactivity
 - deposition on substrates with complex shapes and high aspect ratio

- The system design is determined by the average distance a neutral particle travels before being ionized
- The ionization mean free path is

$$\lambda_{\rm iz} = \frac{v_{\rm s}}{k_{\rm iz} n_{\rm e}}$$

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where

- *v*_s is the velocity of the sputtered neutral metal
- k_{iz} is the ionization rate coefficient
- *n*_e is the electron density

This distance has to be short

- v_s has to be low thermalize the sputtered flux increase discharge pressure
- *n*_e has to be high

v _s [eV]	$T_{\rm e} [{\rm eV}]$	<i>n</i> _e [m ⁻³]	λ_{iz} [cm]
1.5	3	1 × 10 ¹⁷	333
0.05	3	1×10^{17}	61
0.05	3	$1 imes 10^{18}$	6.1
0.05	3	$1 imes 10^{19}$	0.61

 Another important parameter is the fractional ionization of the metal flux

$$\frac{\Gamma_i}{\Gamma_i + \Gamma_n}$$

The ion flux to the substrate is

$$\Gamma_{\rm i} \approx 0.61 \, n_{\rm m+} u_{\rm B} \sim \sqrt{T_{\rm e}}$$

The flux of thermalized neutrals is

$$\Gamma_{n}=\frac{1}{4}\textit{n}_{m}\textit{v}_{Th}\sim\sqrt{\textit{T}_{g}}$$

- Since $T_e \gg T_g$ the fractional ionization of the metal flux is larger than the fraction of ionized metal in the plasma
- It is not necessary to completely ionize the sputtered metal to create a highly ionized flux to the substrate

High Power Impulse Magnetron Sputtering (HiPIMS)

- In a conventional dc magnetron discharge the power density is limited by the thermal load on the target
- In a HiPIMS discharge a high power pulse is supplied for a short period
 - Iow frequency
 - Iow duty cycle
 - low average power
- The high power pulsed magnetron sputtering discharge uses the same sputtering apparatus except the power supply



HiPIMS - Power supply





- The high power pulsed discharge operates with a
 - Cathode voltage in the range of 500 2000 V
 - Current densities of 3 4 A/cm²
 - Power densities in the range of 1 3 kW/cm²
 - Average power 200 600 W
 - Frequency in the range of 50 1000 Hz
 - Duty cycle in the range of 0.5 5 %

HiPIMS - Power supply



- The exact pulse shape is determined by the load
 - the discharge formed
 - it depends on the gas type and gas pressure



(After Bohlmark et al. (2005) and Guðmundsson et al. (2006))

- Temporal and spatial variation of the electron density
- Argon discharge at 20 mTorr with a titanium target
- The electron density in the substrate vicinity is of the order of 10¹⁸ 10¹⁹ m⁻³



- The spatial variation of the electron density at 65 μ s and 230 μ s from the initiation for gas pressure of 10 mTorr.
- The pulse is 90 µs long and the average power 270 W and the target made of copper
- The electron density is uniform along the radius of the discharge



(After Gudmundsson et al. (2002))

- The electron density versus time from the initiation of the pulse 9 cm below the target
- The pulse is 100 μs long and the average power 300 W and the target made of tantalum
- A strong initial peak appears
- A second peak appears later in time at higher pressure

- The electron density depends on the target material
 - Cr target gives higher density than Ti
 - higher [Cr⁺]/[Ar⁺] than [Ti⁺]/[Ar⁺] ratio
- The ionization of metal atoms plays an important role in the creation of electrons







- The electron saturation current as a function of location and time from pulse initiation
- The argon pressure was 5 mTorr and 20 mTorr, the target was made of titanium, and the pulse energy 6 J

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A monotonic rise in plasma density with discharge gas pressure and applied power is generally observed



- Each peak travels with a fixed velocity through the chamber
- The peaks travel with a velocity of 5.3×10^3 m/s at 1 mTorr, 1.7×10^3 m/s at 5 mTorr, and 9.8×10^2 m/s at 20 mTorr

- The plasma density versus time while varying the
 - sputtering gas
 - chamber dimension
 - distance to target
 - applied power
- The first peak appears immediately after the plasma ignition
- The peaks increase with increased applied power

(From Alami et al. (2005))



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- The second peak appears only for pressures above 5 mTorr
- The lighter the gas atom the earlier the peaks appear
- Decreased chamber radius results in earlier appearance of the second peak
 - we propose that the charged particles travel as sound waves
 - the second peak is a reflection from the walls

(From Alami et al. (2005))



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HiPIMS - Electron energy



- The electron energy probability function (EEPF) under the race-track 100 mm below the target for an argon discharge at 3 (dashed) and 20 (solid) mTorr with a copper target
- The EEPF is more broad at low pressure and early in the pulse

HiPIMS - Electron energy



- Temporal variation of the effective electron temperature 100 mm below the target under the race-track (r = 40 mm)
- The electron energy decreases with increased discharge pressure

- Conventional dc magnetron discharge -Pre-ionization - violet argon discharge
- HiPIMS discharge averaged over several pulses - green discharge characteristic of Cu vapour
- The Cu⁺ lines are only observed in HiPIMS mode



(From Vašina et al. (2007))

- There have been conflicting reports on the ionized flux fraction
 - 70 % for Cu (Kouznetsov et al., 1999)
 - 92 % for Cu (Vlček et al., 2007)
 - 40 % for Ti_{0.5}Al_{0.5} (Macák et al., 2000)
 - 9.5 % for AI (DeKoven et al., 2003)
 - 4.5 % for C (DeKoven et al., 2003)
- The degree of ionization
 - 90 % for Ti (Bohlmark et al., 2005)
- The ionization flux fraction depends on applied power, pulse frequency and pulse length



(From Bohlmark et al. (2005))

HiPIMS - Ion energy

- The time averaged ion energy distribution for Ar⁺ and Ti⁺ ions
- The gas pressure was 3 mTorr, pulse energy 3 J and 10 J and the target made of Ti
- The ion energy distribution is broad to over 100 eV
- About 50 % of the Ti⁺ ions have energy > 20 eV



(From Bohlmark et al. (2006))

HiPIMS - Ion energy

- Significant fraction of the Ti⁺ ions are transported radially outwards
- Direction dependent high energy-tail



(From Lundin et al. (2008))



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- The ion flux versus time measured by a mass spectrometer (20 μs windows)
- The gas pressure was 3 mTorr, pulse energy 8 J and the target made of Ti
- Highly metallic ion flux during the active phase of the discharge



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(From Bohlmark et al. (2006))

- During the initial stages of the pulse Ar⁺ ions dominate the discharge
- Later in the pulse metal ions build up and become the abundant ion species
- Multiply charged ions have been observed
- Significant fraction of the ion flux is Ti²⁺ (Bohlmark et al., 2006)
- Ti⁴⁺ ions have been observed (Andersson et al., 2008)



From Bohlmark et al. (2006)



 Gasless self-sputtering of copper has been demonstrated

(Andersson and Anders, 2009)

- This self-sputtering in vacuum can deliver extraordinarily high metal-ion current
- The usable ion current increased exponentially with increasing discharge voltage

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Self-Sputtering Far above the Runaway Threshold: An Extraordinary Metal-Ion Generator

Joakim Andersson and André Anders mer Berkeley National Laboratory: 1 Cyclorow Road, Berkeley, Cultfornia 94720, USA (Received 12 September 2008; published 27 January 2007)

When ell-spanneting is driven for above the manosys threshold voltage, enceptie electrons are made artillels to spokes. "Recose plears" fifter the magnetize target. Instation blance convidentions show that the accordary electrons defirer the neutrenzy range to the "menor" new. Thereby, such a system cub ne are encodinarily prefile generation of used to main lines. Centry to obte income sources, the instantial is substatic can exceed the discharge current. For galaxs self-spatieting of corpor, the solid is no current so a substatic can exceed the discharge current. For galaxs self-spatieting of corpor, the solid is no current solid self-spatieting self-spatieting of corpor, the

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PACS numbers: \$2.80 Vp, 52.25 Jrs, 52.40 HL 81.15 Cd

Large fluxes of ions are of interest to a number of plasma-based technologies such as self-ion assisted deposition of films and high-current and large-area ion sources. The generation of large ion fluxes is a challenging task because plasma systems tend to produce just as many ions as necessary to maintain the discharge. Hence, only a small fraction of the generated ions can be utilized for processing. Among the most prolific generators of ions are cathodic are discharges, where the available ion current is generally quantified by normalizing it to the discharge current; the ratio is typically about 0.1 [1]. In this contrinetron sputtering (HIPIMS) can be an extremely prolific generator of metal ions that, under certain conditions, can deliver ion currents that even exceed the discharge current. We will show that this very high level is consistent with common marticle and energy balance considerations.

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The correst-solary-time characteristics of HIPMS dicharges in hadgened gas [10,11] who the far of milciently leng pulses (hypitally >100 μ s) at constant voltage, the current may go though a maximum and then strike at an equilibrium value. The current reduction after the initial pools in site to gas correlation. *Mosever, if* the power drensity is high, the current reduction *Mosever*, the ourplexity different in that, at a world-relation teleptic threshold, the current does not reduce but jumps to a new, much high review. This for the threshold of stantable

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self-spatning [7]. At the threshold, self-spatning are first list and the self-spatnetic parameter exceeds utily, II = $\alpha J \gamma_{NS} > 1$, where α is the probability that a spattand atom is insized, β is the probability that a spatquencing spatial. All three quantities are time dependent to the space of the probability of the nextspatnetic spatial. All three quantities are time dependent to the space of the probability of the nextspat spatial spatial of the probability of the nextspat spatial spatial

Copper is a puedrard matchal for studying southed adispartnring because the southing statution, II = 1, can be obtained at manageable, robative how power densities (e.g. -1 kW/mc) averaged over the target area). Recently, it was shown that copper allows pasks thigh vacuum) self-spartnergies to occur when the magnetized dicharge publics are "lickitattral" via short sacura-are phaser publics (II) with lices the work of "galdes" galtering because it avoids the modeling complications assotiated with phases containing both gas and neal species: and work phases containing both gas and neal species.

The current to a negatively biased ion collector, i.e., large probe operating in the ion saturation current, is given by the area integral over the current density $I_i = \int f_i dA$, with the Bohm current [13]

$$j_i = 0.61 n_{i0} \tilde{Q} t \left(\frac{kT_{i0}}{m_j} \right)^{1/2}$$
, (1)

where a_{12} is the loss density at the edge of the shearth (hinks: "0") of the collector, Q_1 is the mass in charge state number, a_1 is the elementary charge, $(M_{2,0}^{-1}(m_0)^{-2})$ is the local ion scored valcely which depends or the element temperature, T_{a0} and the ion mass, L is the Betzmann constant, in the devices in the full temperature that $M_{2,0}^{-1}(m_0)^{-2}$ the mass in the mass in the result of the collectors corretors. There are a single descriptions of endemonent in the discuss the fully-init this approximations will suffice that

To determine the ion density in (1), we should consider the ion balance equation at the collector's sheath edge (omitting the index 0 for simplicity)

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HiPIMS - Deposition rate

- Several groups report on a significantly lower deposition rate for HiPIMS as compared to dcMS
 - a factor of 2 lower deposition rate for Cu and Ti thin films (Bugaev et al., 1996)
 - a factor of 4 7 lower deposition rate for reactive sputtering of TiO₂ from a Ti target (Davis et al., 2004)
 - a factor of 3 4 lower deposition rate for reactive sputtering of AlO_x from an Al target (Sproul et al., 2004)
 - the reduction in deposition rate decreases with decreased magnetic confinement (weaker magnetic field)

(Bugaev et al., 1996)



HiPIMS - Deposition rate

- One explanation is that the sputtered material is ionized close to the target and many of the metallic ions will be attracted back to the target surface by the cathode potential
- A reduction in the deposition rate would occur mainly for metals with a low self-sputtering yield
- A significant fraction of the ions of the sputtered material are transported sideways
- Maybe this can be reduced by optimized magnetic confinement



Application - Trench filling



- Ta thin films grown on Si substrates placed along a wall of a 2 cm deep and 1 cm wide trench
 - conventional dc magnetron sputtering (dcMS)
 - high power impulse magnetron sputtering (HiPIMS)
- Average power is the same 440 W
- They were compared by scanning electron microscope (SEM), transmission electron microscope (TEM)

Application - Trench filling



dc magnetron HiPIMS

- dcMS grown films exhibit rough surface, pores between grains and inclined columnar structure, leaning toward the aperture
- Ta films grown by HiPIMS have smooth surface, and dense crystalline structure with grains perpendicular to the substrate

HiPIMS - Applications

- HiPIMS has already been demonstrated on an industrial scale (Ehiasarian et al., 2006)
- Due to the absence of a secondary discharge in the reactor an industrial reactor can be upgraded to become IPVD device by changing the power supply



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Summary

- We reviewed the measured plasma parameters of the high power impulse magnetron sputtering discharge (HIPIMS)
- Power supply
 - Essentially the same sputtering apparatus except for the power supply
- Electron density
 - Roughly 2 orders of magnitude higher in the substrate vicinity than for a conventional dc magnetron sputtering discharge
- Plasma dynamics
 - The peak electron density travels away from the target with fixed velocity

Summary

Ionization fraction

- Ionization fraction is high, mainly due to the high electron density
- The ions on the inert gas and the ions of the sputtered vapor are separated in time
- Deposition rate
 - Deposition rate is lower than in a conventional dc magnetron sputtering discharge, maybe due to self sputtering

Acknowlegdements



Can be downloaded at

http://www.raunvis.hi.is/~tumi/hipims.html

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